



深圳市东信通电子科技有限公司

ShenZhen Eastong Electronic technology Co., LTD

APPROVAL SHEET
FOR
时睿科技 JV105

Issued by		Checked by	
Confirmed by		Date	2025-07-02
Customer Confirm			

Project: 时睿科技 JV105		Author: 许小荣	File Name: <div>时睿科技 JV105-APP-RA</div>
Date: 2025-07-02			
Rev:	Language:	Check:	
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Revision History

Date	Revision	Description of Changes
2025-07-02	R:A	Antenna performance approved by customer

1 SUMMARY

2 GENERAL DESCRIPTION

2.1 Definitions

3 MECHANICAL DESCRIPTION

4 ELECTRICAL PERFORMANCE

4.1 Set-up

- 4.1.1 VSWR and return loss
- 4.1.2 Efficiency, Gain and TRP/TIS
- 4.1.3 Matching Circuit Description

4.2 Measurement Data

- 4.2.1 VSWR
- 4.2.2 Active result

5 MECHANICAL DRAWING

6 CONCLUSION

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1 Summary

This report summarizes the electrical results of the proposed antenna to support the program. We test the antenna with the latest version handset .

2 General Description

2.1 Definitions

VSWR: Voltage Standing Wave Rate

3 Mechanical Description

4 Electrical Performance

4.1 Set-up

4.1.1 VSWR and return loss

VSWR measurements (S_{11}) were performed using an Agilent E5070B Network Analyzer and the previously described test fixture. Coaxial chokes were used to mitigate surface currents on the outside of the cabling. The testing was performed in free space.

4.1.2 Efficiency, Gain and TRP/TIS

The gain of the antenna was measured in Dong Xin's 3D anechoic chamber in Shenzhen. The chamber is capable of doing tests from 380MHz to 6GHz. Coaxial chokes on the feed cable were used to mitigate surface currents. The measurement results are calibrated using dipole standards. For TRP and TIS the chamber uses a Agilent 8960 to establish the connection with the mobile device. During TRP tests the 8960 reads the power received through the chamber probes whilst during TIS tests the 8960 transmits through the probe. All data is afterwards corrected by a calibration table.

4.1.3 Matching Circuit Description

No matching.

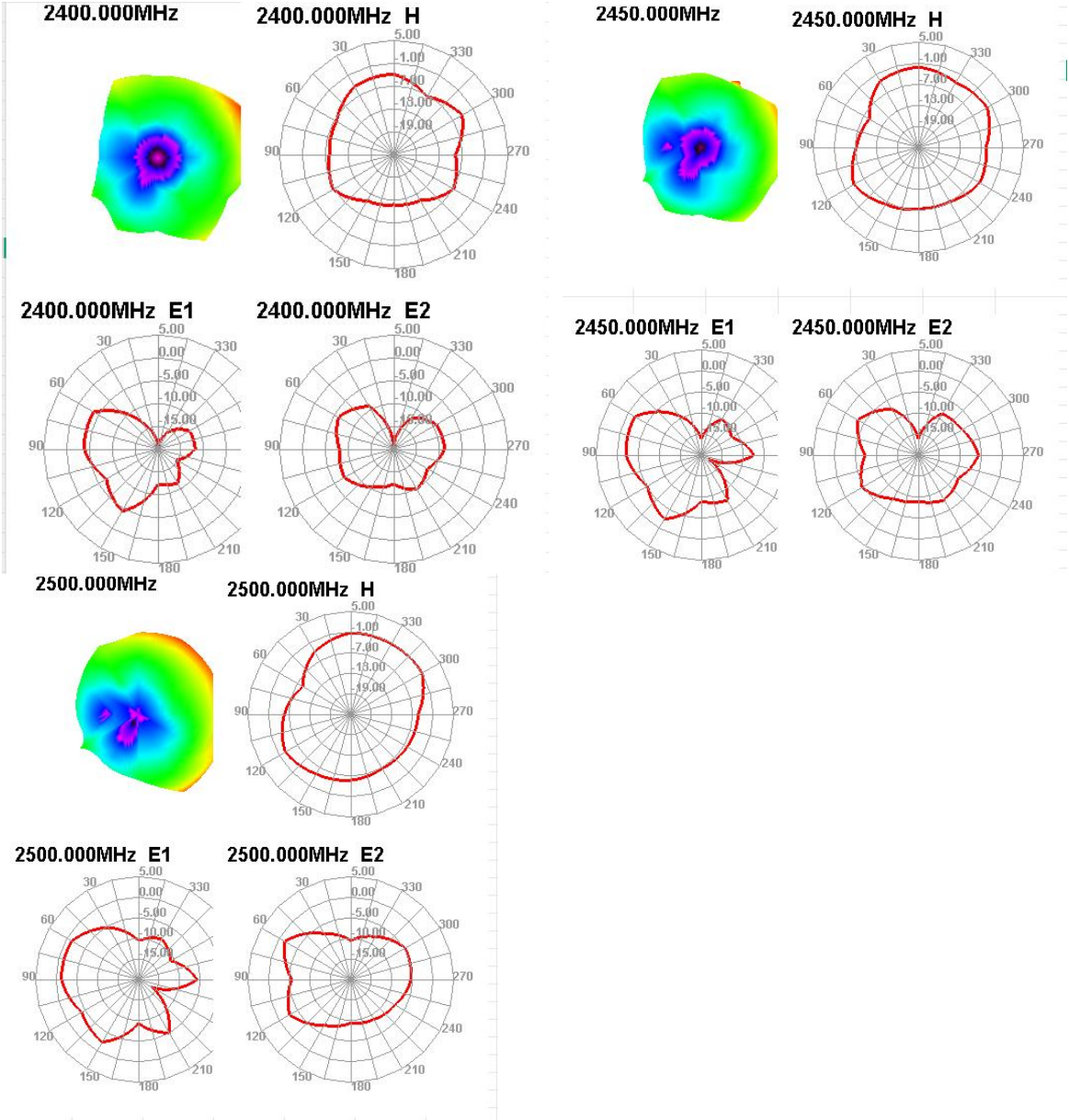
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4.2 Measurement Data

效率与增益:

Freq (MHz)	Effi (%)	Gain (dBi)
2400	27.49	1.68
2450	27.88	1.88
2500	34.16	1.93

2D, 3D:



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